

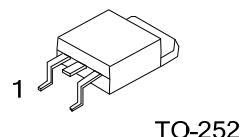
UTT16P10

Power MOSFET

-100V, -16A P-CHANNEL
POWER MOSFET

■ DESCRIPTION

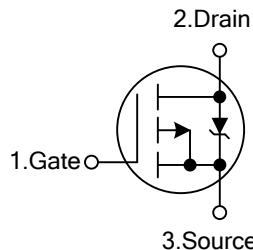
The UTC **UTT16P10** is a P-channel power MOSFET using UTC's advanced technology to provide the customers with high switching speed, cost-effectiveness and a minimum on-state resistance. It can also withstand high energy in the avalanche.



■ FEATURES

- * $R_{DS(ON)} \leq 0.21 \Omega$ @ $V_{GS}=-10V$, $I_D=-16A$
- * High Switching Speed

■ SYMBOL



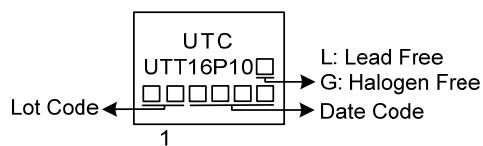
■ ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free	Halogen Free		1	2	3	
UTT16P10L-TN3-R	UTT16P10G-TN3-R	TO-252	G	D	S	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

UTT16P10G-TN3-R	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) TN3: TO-252 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING



■ ABSOLUTE MAXIMUM RATINGS ($T_J=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	-100	V
Gate-Source Voltage		V_{GSS}	± 20	V
Drain Current	Continuous, $V_{GSS} @ -10\text{V}$	$T_C = 25^\circ\text{C}$	I_D	-16
		$T_C = 100^\circ\text{C}$		-9.8
	Pulsed (Note 2)		I_{DM}	-30
Avalanche Energy	Repetitive (Note 3)	E_{AS}	60	mJ
Peak Diode Recovery dv/dt		dv/dt	-3.42	V/ns
Power Dissipation ($T_C=25^\circ\text{C}$)		P_D	45	W
Junction Temperature		T_J	-55 ~ +150	$^\circ\text{C}$
Storage Temperature		T_{STG}	-55 ~ +150	$^\circ\text{C}$

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.
 Absolute maximum ratings are stress ratings only and functional device operation is not implied.
 2. Repetitive rating; pulse width limited by max. junction temperature.
 3. $V_{DD}=-25\text{V}$, starting $T_J=25^\circ\text{C}$, $L=2.7\text{mH}$, $R_G=25\Omega$, $I_{AS}=-6.6\text{A}$.

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	110	$^\circ\text{C/W}$
Junction to Case	θ_{JC}	2.77	$^\circ\text{C/W}$

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

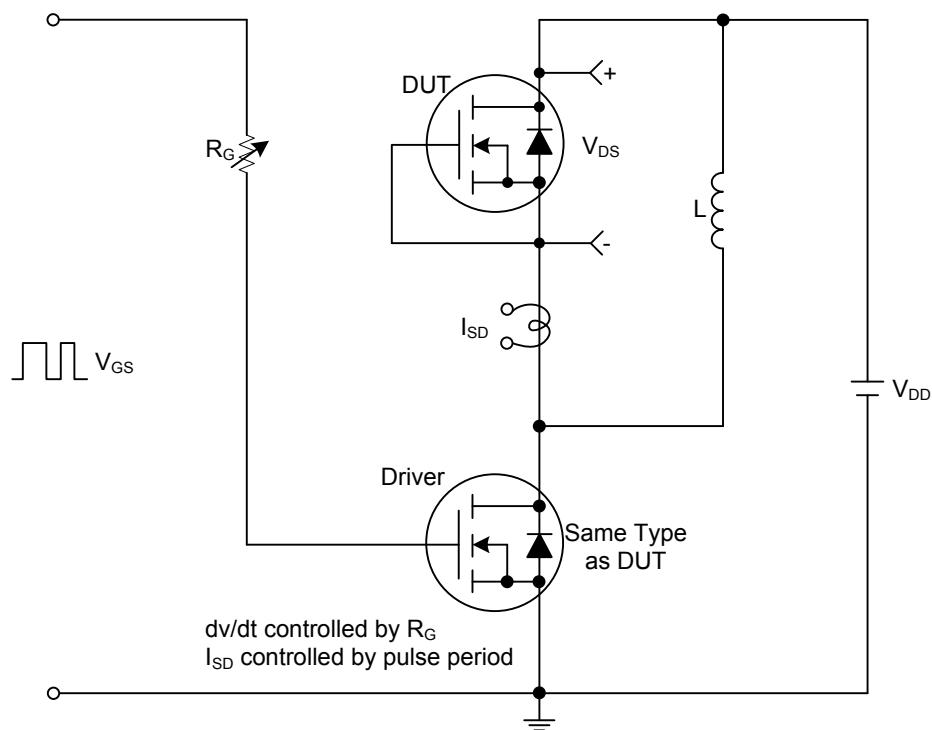
■ ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D=-250\mu\text{A}, V_{GS}=0\text{V}$	-100			V
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_D=-1\text{mA}$		-0.1		V°C
Drain-Source Leakage Current	I_{DSS}	$V_{DS}=-100\text{V}, V_{GS}=0\text{V},$ $V_{DS}=-80\text{V}, V_{GS}=0\text{V}, T_J=150^\circ\text{C}$		-25	μA	
Gate- Source Leakage Current	Forward Reverse	I_{GSS} $V_{GS}=+20\text{V}$ $V_{GS}=-20\text{V}$		+100	nA	
ON CHARACTERISTICS						
Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{DS}=V_{GS}, I_D=-250\mu\text{A}$	-1.0		-3.0	V
Static Drain-Source On-State Resistance	$R_{\text{DS(ON)}}$	$V_{GS}=-10\text{V}, I_D=-16\text{A}$ (Note 2)		0.21		Ω
DYNAMIC PARAMETERS						
Input Capacitance	C_{ISS}	$V_{DS}=-25\text{V}, V_{GS}=0\text{V}, f=1.0\text{MHz}$		1500	1900	pF
Output Capacitance	C_{OSS}			82		pF
Reverse Transfer Capacitance	C_{RSS}			68		pF
SWITCHING PARAMETERS						
Total Gate Charge	Q_G	$V_{DS}=-80\text{V}, V_{GS}=-10\text{V}, I_D=-16\text{A}$		36	60	nC
Gate to Source Charge	Q_{GS}			9.4		nC
Gate to Drain ("Miller") Charge	Q_{GD}			6.4		nC
Turn-ON Delay Time	$t_{D(\text{ON})}$	$V_{DD}=-50\text{V}, I_D=-16\text{A}, R_G=9.1\Omega$		5.6		ns
Rise Time	t_R			18		ns
Turn-OFF Delay Time	$t_{D(\text{OFF})}$			52		ns
Fall-Time	t_F			25		ns
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Maximum Body-Diode Continuous Current	I_S				-16	A
Maximum Body-Diode Pulsed Current	I_{SM}	(Note 1)			-30	A
Drain-Source Diode Forward Voltage	V_{SD}	$I_S=-16\text{A}, V_{GS}=0\text{V}$ (Note 2)			-2.6	V
Body Diode Reverse Recovery Time (Note 1)	t_{rr}	$I_S=-16\text{A}, V_{GS}=0\text{V},$ $dI_F/dt=100\text{A}/\mu\text{s}$		244		ns
Body Diode Reverse Recovery Charge	Q_{rr}			2.44		μC

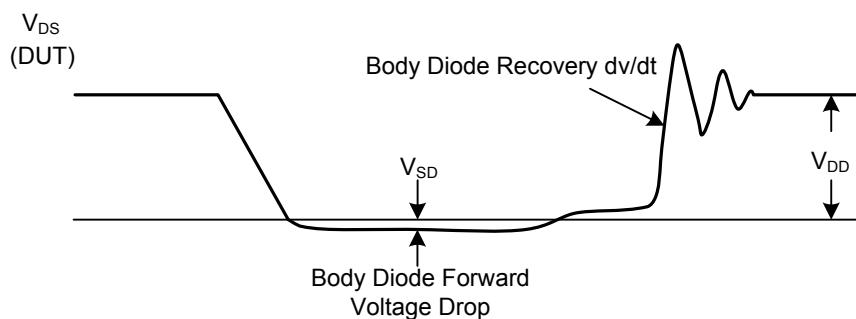
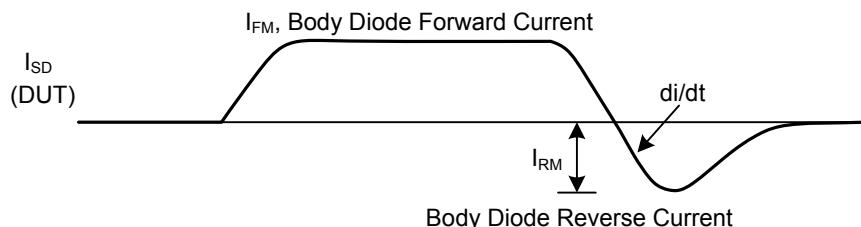
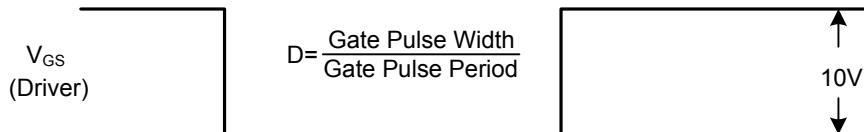
Notes: 1. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

2. Repetitive rating; pulse width limited by max. junction temperature.

■ TEST CIRCUITS AND WAVEFORMS



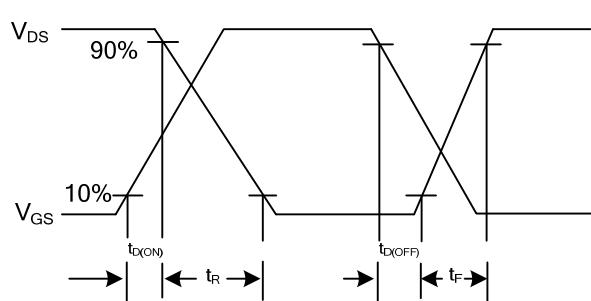
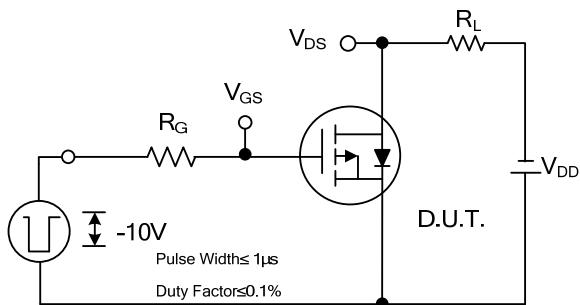
Peak Diode Recovery dV/dt Test Circuit



Peak Diode Recovery dV/dt Test Circuit and Waveforms

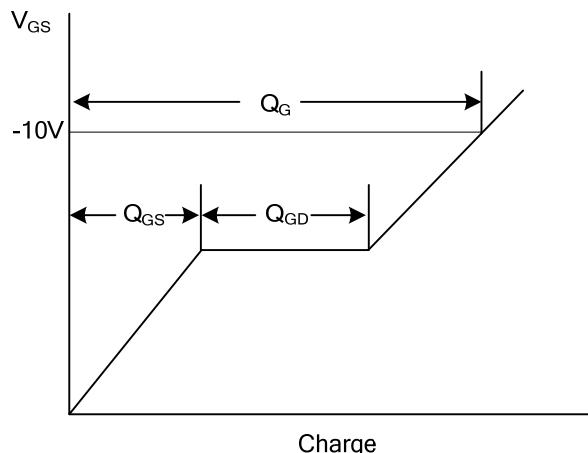
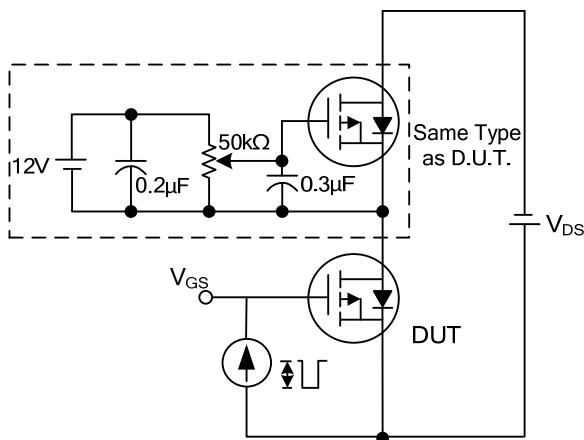
Peak Diode Recovery dV/dt Waveforms

■ TEST CIRCUITS AND WAVEFORMS



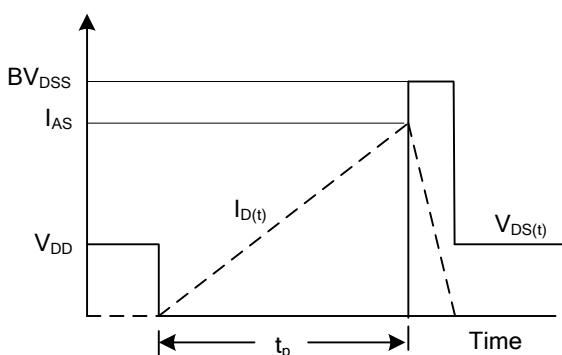
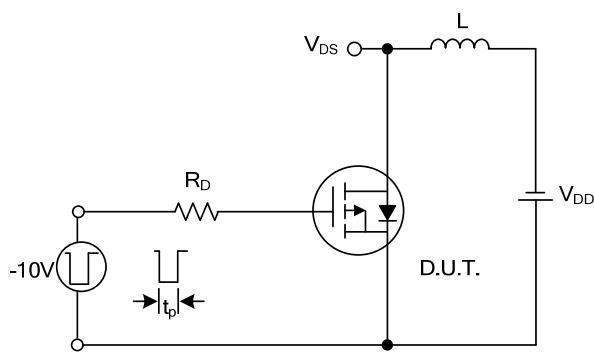
Switching Test Circuit

Switching Waveforms



Gate Charge Test Circuit

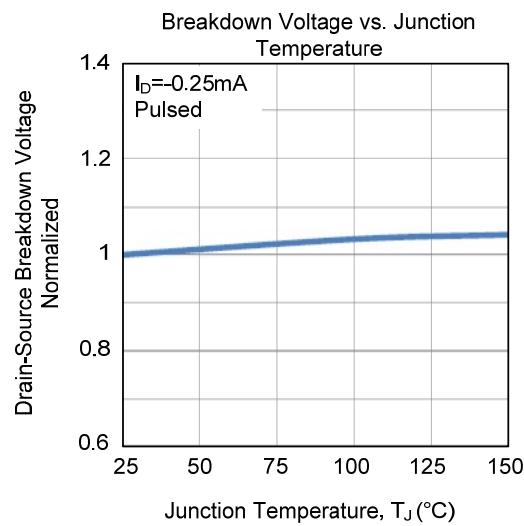
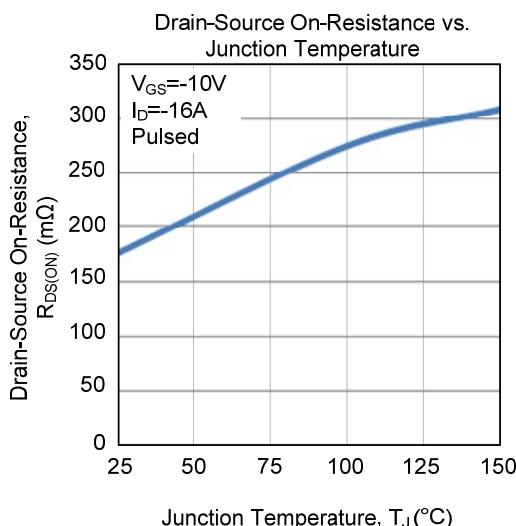
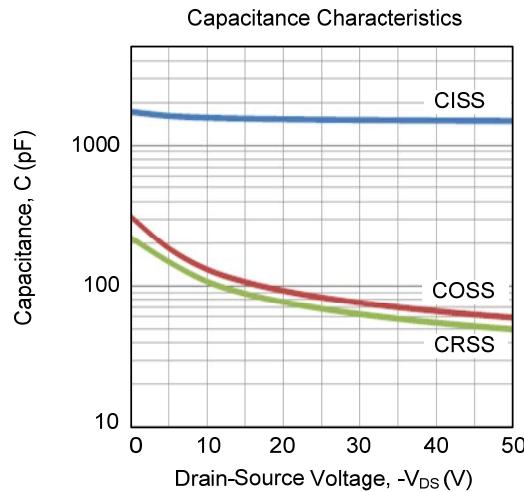
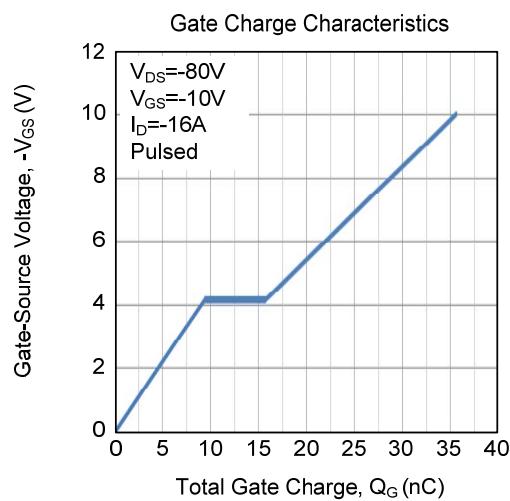
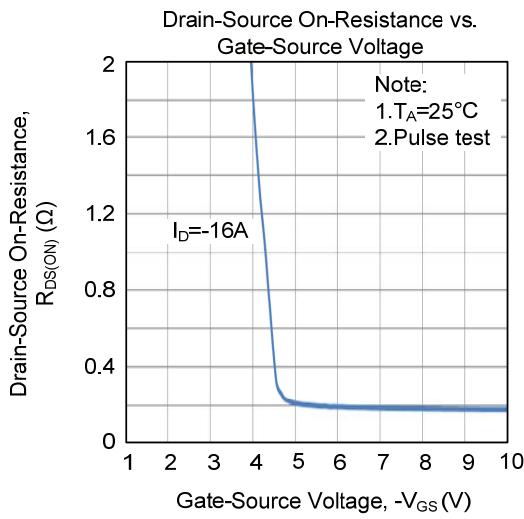
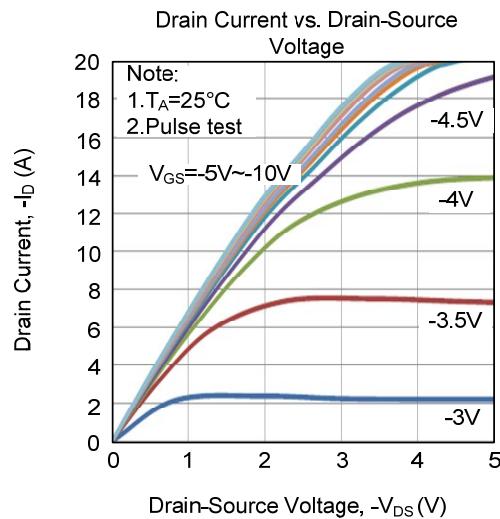
Gate Charge Waveform



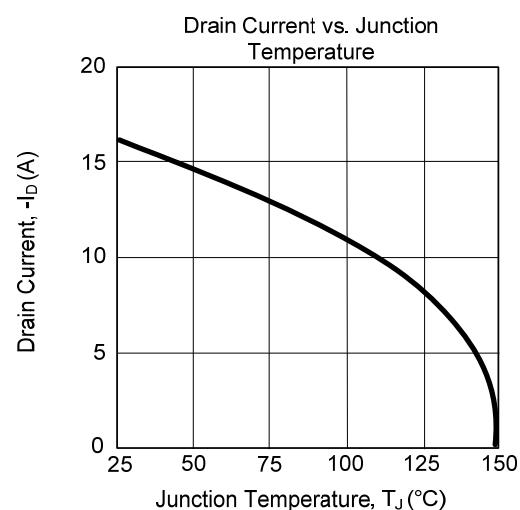
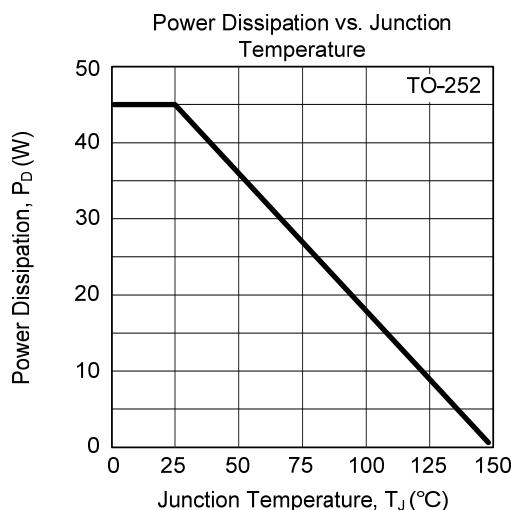
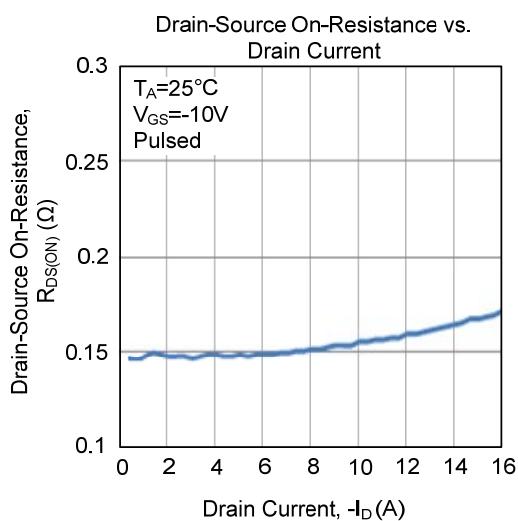
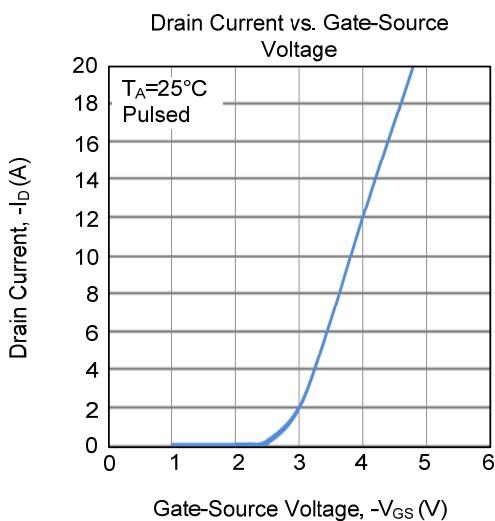
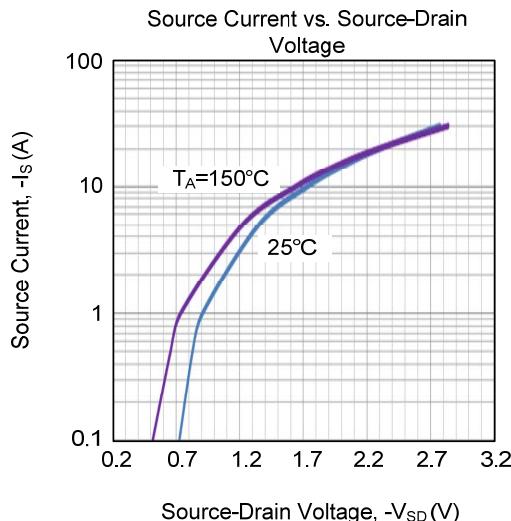
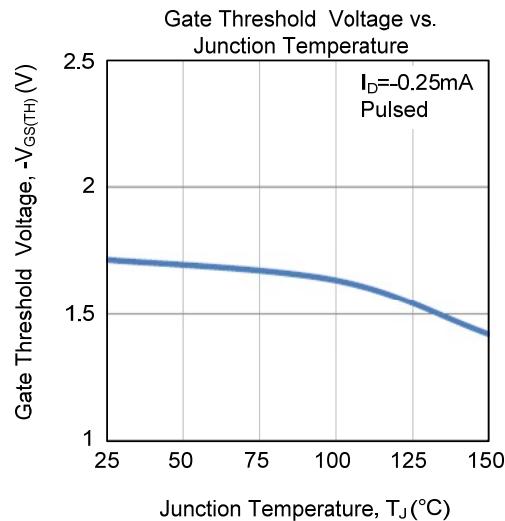
Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

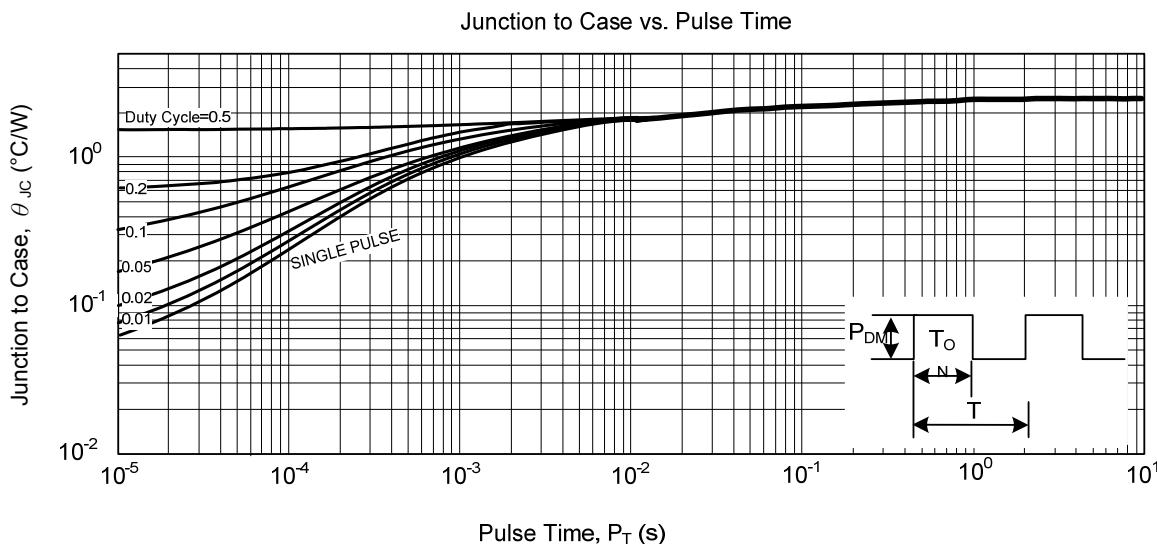
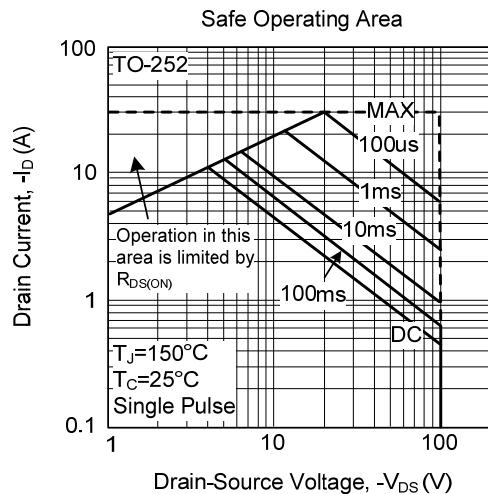
■ TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS (Cont.)



■ TYPICAL CHARACTERISTICS (Cont.)



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